

### **IGBT Modules**

### **SKM 400GA123D**

#### **Features**

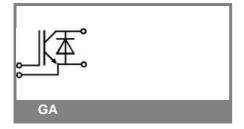
- MOS input (voltage controlled)
- N channel, homgeneous Si
- · Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 x I<sub>cnom</sub>
- · Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DBC Direct Copper Bonding Technology
- Large clearance (12 mm) and creepage distances (20 mm)

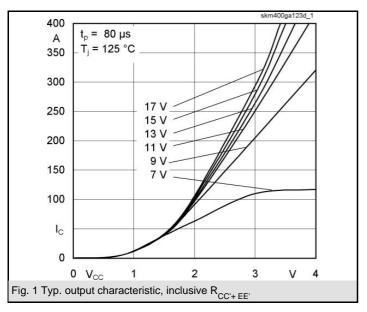
### **Typical Applications**

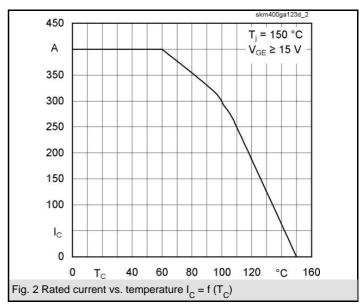
• Switching (not for linear use)

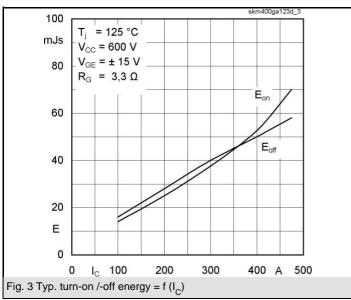
Absolute Maximum Ratings T <sub>c</sub> = 25 °C, unless otherwise specified									
Symbol	Conditions	Values	Units						
IGBT									
$V_{CES}$		1200	V						
V <sub>CES</sub>	T <sub>c</sub> = 25 (80) °C	400 (360)	Α						
I <sub>CRM</sub>	$t_p = 1 \text{ ms}$	600	Α						
$V_{GES}$		± 20	V						
$T_{vj}$ , $(T_{stg})$	$T_{OPERATION} \leq T_{stg}$	- 40 <b>+</b> 150 (125)	°C						
$V_{isol}$	AC, 1 min.	2500	V						
Inverse diode									
I <sub>F</sub>	T <sub>c</sub> = 25 (80) °C	390 (260)	Α						
I <sub>FRM</sub>	$t_p = 1 \text{ ms}$	600	Α						
I <sub>FSM</sub>	$t_p = 10 \text{ ms; sin.; } T_j = 150 ^{\circ}\text{C}$	2900	А						

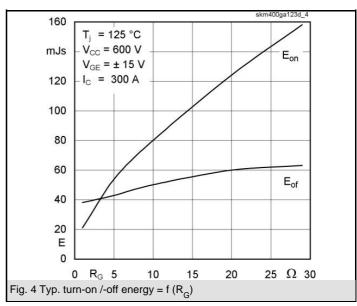
$ \begin{array}{ c c c c c c c c } \hline \textbf{Symbol} & \textbf{Conditions} & \textbf{min.} & \textbf{typ.} & \textbf{max.} & \textbf{Units} \\ \hline \textbf{IGBT} \\ \hline \textbf{V}_{GE(1h)} & \textbf{V}_{GE} = \textbf{V}_{CE}, \textbf{I}_{C} = 12 \text{ mA} \\ \textbf{V}_{CEC(TO)} & \textbf{V}_{GE} = 0, \textbf{V}_{CE} = \textbf{V}_{CES}, \textbf{T}_{j} = 25 (125) ^{\circ} \textbf{C} \\ \textbf{V}_{CE(TO)} & \textbf{V}_{GE} = 15 \text{ V}, \textbf{T}_{j} = 25 (125) ^{\circ} \textbf{C} \\ \textbf{V}_{CE(TO)} & \textbf{V}_{GE} = 15 \text{ V}, \textbf{T}_{j} = 25 (125) ^{\circ} \textbf{C} \\ \textbf{V}_{CE(3al)} & \textbf{I}_{Comm} = 300 \text{ A}, \textbf{V}_{GE} = 15 \text{ V}, \text{chip level} \\ \textbf{C}_{ies} & \textbf{under following conditions} \\ \textbf{C}_{ces} & \textbf{V}_{GE} = 0, \textbf{V}_{CE} = 25 \text{ V}, \textbf{f} = 1 \text{ MHz} \\ \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf{M}_{CC} \\ \textbf{M}_{CC} & \textbf$								
$ \begin{array}{ c c c c } \textbf{IGBT} \\ V_{GE(th)} & V_{GE} = V_{CE}, \ I_{C} = 12 \ \text{mA} \\ V_{CE(TO)} & V_{GE} = 0, \ V_{CE} = V_{CES}, \ T_{j} = 25 \ (125) \ ^{\circ}\text{C} \\ \hline V_{CE(TO)} & T_{j} = 25 \ (125) \ ^{\circ}\text{C} \\ \hline V_{CE(TO)} & V_{GE} = 15 \ \text{V}, \ T_{j} = 25 \ (125) \ ^{\circ}\text{C} \\ \hline V_{CE(TO)} & V_{GE} = 15 \ \text{V}, \ T_{j} = 25 \ (125) \ ^{\circ}\text{C} \\ \hline V_{CE(SHI)} & I_{Comm} = 300 \ \text{A}, \ V_{GE} = 15 \ \text{V}, \ \text{chip level} \\ \hline V_{CE(SHI)} & I_{Comm} = 300 \ \text{A}, \ V_{GE} = 15 \ \text{V}, \ \text{chip level} \\ \hline V_{Ce(SHI)} & I_{Comm} = 300 \ \text{A}, \ V_{GE} = 15 \ \text{V}, \ \text{chip level} \\ \hline V_{Ce(SHI)} & I_{Comm} = 300 \ \text{A}, \ V_{GE} = 25 \ \text{V}, \ \text{f} = 1 \ \text{MHz} \\ \hline V_{Ce(SHI)} & I_{Comm} = 300 \ \text{A}, \ V_{CE(SHI)} \\ \hline V_{Ce(SHI)} & I_{Comm} = 300 \ \text{A}, \ V_{CE(SHI)} \\ \hline V_{Ce(SHI)} & I_{Comm} = 300 \ \text{A}, \ V_{CE(SHI)} \\ \hline V_{GE} & = 0, \ V_{CE} = 25 \ \text{V}, \ \text{f} = 1 \ \text{MHz} \\ \hline V_{Ce(SHI)} & I_{Comm} = 300 \ \text{A} $	Characteristics		T <sub>c</sub> = 25 °C, unless otherwise specified					
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Symbol	Conditions	min.	typ.	max.	Units		
$\begin{array}{c} I_{CES} \\ V_{GE}(TO) \\ V_{CE(TO)} \\ V_{CE}(TO) \\ V_{GE} = 0, V_{CE} = V_{CES}, T_j = 25  (125)  ^{\circ}C \\ V_{CE(TO)} \\ V_{CE}(TO) \\ V_{GE} = 15  ^{\circ}V, T_j = 25  (125)  ^{\circ}C \\ V_{GE} = 15  ^{\circ}V, T_j = 25  (125)  ^{\circ}C \\ V_{GE}(Sat) \\ V_{CE(Sat)} \\ V_{CE$	IGBT		•					
$ \begin{array}{llllllllllllllllllllllllllllllllllll$	$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_{C} = 12 \text{ mA}$	4,5	5,5	6,5	V		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		$V_{GE} = 0, V_{CE} = V_{CES}, T_{j} = 25 (125) ^{\circ}C$		0,1	0,3	mA		
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	V <sub>CE(TO)</sub>			1,4 (1,6)	1,6 (1,8)	V		
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$		V <sub>GE</sub> = 15 V, T <sub>j</sub> = 25 (125) °C		3,66 (5)	4,66 (6,33)	mΩ		
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	V <sub>CE(sat)</sub>	$I_{Cnom}$ = 300 A, $V_{GE}$ = 15 V, chip level		2,5 (3,1)	3 (3,7)	V		
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	C <sub>ies</sub>	under following conditions		22	30	nF		
$ \begin{array}{c} C_{res} \\ L_{CE} \\ R_{CC'+EE'} \\ \end{array}                                  $	C <sub>oes</sub>	$V_{GE} = 0$ , $V_{CE} = 25 V$ , $f = 1 MHz$		3,3	4	nF		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	C <sub>res</sub>			1,2	,	nF		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	L <sub>CE</sub>				20	nH		
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	R <sub>CC'+EE'</sub>	_		0,18 (0,22)		mΩ		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t <sub>d(on)</sub>				400	ns		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t <sub>r</sub>	$R_{Gon} = R_{Goff} = 3.3 \Omega, T_j = 125 °C$			220	ns		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t <sub>d(off)</sub>	V <sub>GE</sub> = ± 15 V				ns		
$ \begin{array}{ c c c c c } \hline \textbf{Inverse diode} \\ V_F = V_{EC} &  _{F_{DOm}} = 300 \text{ A}; V_{GE} = 0 \text{ V}; T_j = 25 (125) & 2 (1.8) & 2.5 & V \\ \hline V_{(TO)} & T_j = 125 () ^{\circ}C & 1.2 & V \\ T_T & T_j = 125 () ^{\circ}C & 2.5 & 3.5 & m\Omega \\ I_{RRM} & I_{Fnom} = 300 \text{ A}; T_j = 25 (125) ^{\circ}C & 85 (140) & A \\ Q_{rr} & di/dt = 2000 \text{ A}/\mu\text{s} & 13 (40) & \mu C \\ \hline E_{rr} & V_{GE} = V & mJ \\ \hline \hline \textbf{Thermal characteristics} \\ \hline R_{th(j-c)} & per IGBT & 0.045 & K/W \\ R_{th(j-c)D} & per Inverse Diode & 0.125 & K/W \\ R_{th(c-s)} & per module & 0.038 & K/W \\ \hline \textbf{Mechanical data} \\ \hline M_s & to heatsink M6 & 3 & 5 & Nm \\ M_t & to terminals M6, M4 & 2.5 & 5 & Nm \\ \hline \end{array} $	t <sub>f</sub>			80	100	ns		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$E_{on} (E_{off})$			38 (40)		mJ		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Inverse diode							
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	$V_F = V_{EC}$	$I_{Fnom}$ = 300 A; $V_{GE}$ = 0 V; $T_j$ = 25 (125) $^{\circ}$ C		2 (1,8)	2,5	V		
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	V <sub>(TO)</sub>	T <sub>i</sub> = 125 () °C			1,2	V		
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	r <sub>T</sub>			2,5	3,5	mΩ		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	I <sub>RRM</sub>			85 (140)		Α		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$Q_{rr}$	di/dt = 2000 A/μs		13 (40)		μC		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	E <sub>rr</sub>	V <sub>GE</sub> = V				mJ		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Thermal characteristics							
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	R <sub>th(i-c)</sub>	per IGBT			0,045	K/W		
R <sub>th(c-s)</sub> per module 0,038 K/W   Mechanical data   M <sub>s</sub> to heatsink M6 3 5 Nm   M <sub>t</sub> to terminals M6, M4 2,5 5 Nm	R <sub>th(j-c)D</sub>	per Inverse Diode			0,125	K/W		
Mechanical data   Ms to heatsink M6 3 5 Nm   Mt to terminals M6, M4 2,5 5 Nm	R <sub>th(c-s)</sub>	per module			0,038	K/W		
M <sub>t</sub> to terminals M6, M4 2,5 5 Nm	Mechanical data							
	$M_s$	to heatsink M6	3		5	Nm		
w 330 g	M <sub>t</sub>	to terminals M6, M4	2,5		5	Nm		
	w				330	g		

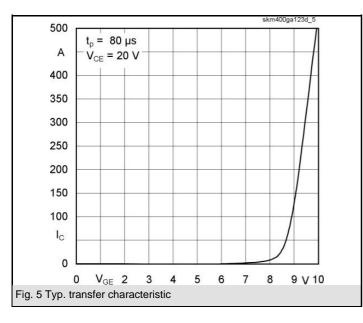


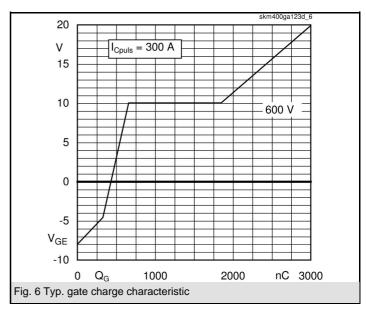


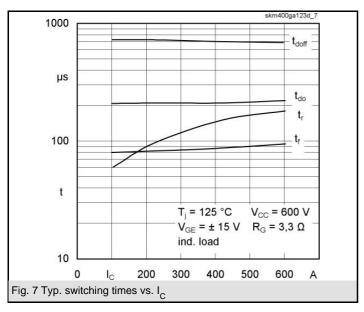


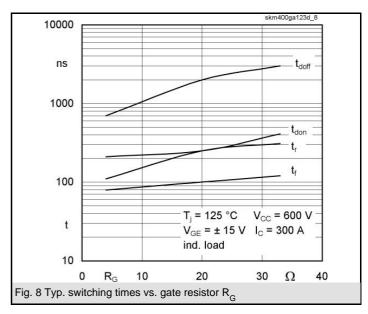


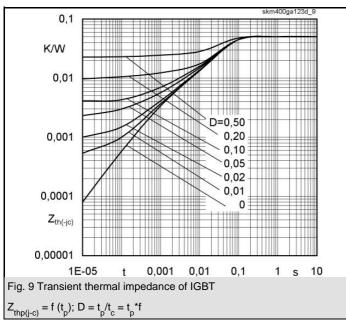


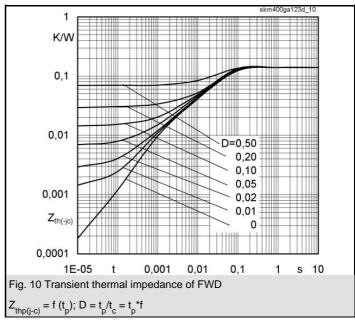


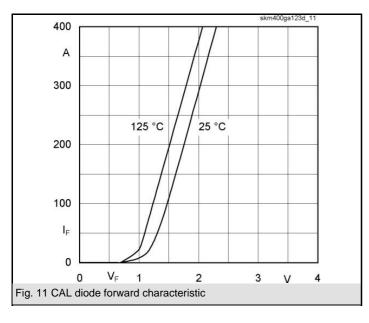


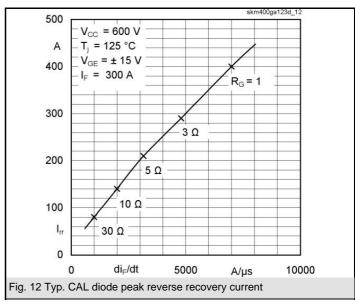


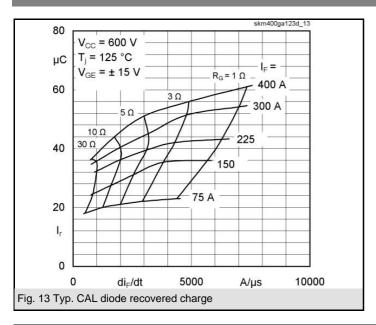


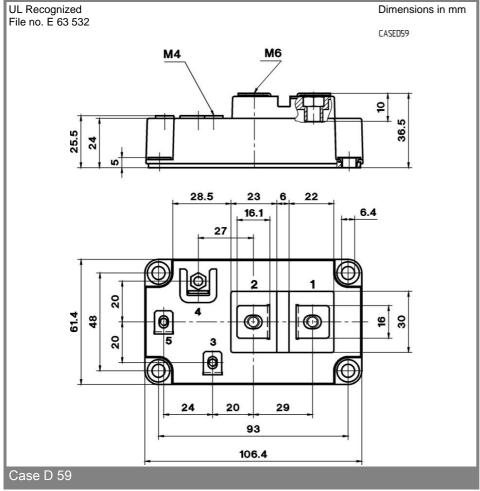


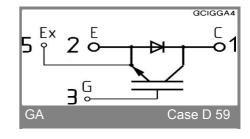












This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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